

<b>Notice of References Cited</b>	Application/Control No. 09/927,642	Applicant(s)/Patent Under Reexamination WALKER ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	IEEE 100 - The Authoritative Dictionary of IEEE Standards Terms, 7 <sup>th</sup> Edition, Standards Information Network, IEEE Press, 2000, p. 339.
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